

**Search Notes**

Application/Control No.

10/531,884

Examiner

Karen Cheng

Applicant(s)/Patent under  
Reexamination

HAIGH ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner
548	517	4/9/2007	KC
544	410	4/9/2007	KC
546	279.1	4/9/2007	KC
548	202, 235	4/9/2007	KC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (see attached)	4/6/2007	KC
Inventor Name Search (PALM)	4/6/2007	KC
EAST Search (see attached)	4/9/2007	KC